

MN3716MFE, MN3716MAE

6mm (1/3 inch) 512H High-Responsivity CCD Area Image Sensors

■ Overview

The MN3716MFE and MN3716MAE are 6mm (1/3 inch) Interline Transfer CCD (IT-CCD) solid state image sensor devices.

This device uses photodiodes in the optoelectric conversion section and CCDs for signal read out. The electronic shutter function has made possible an exposure time of 1/10000 seconds. Further, this device has the features of high sensitivity, low noise, broad dynamic range, and extremely low smear.

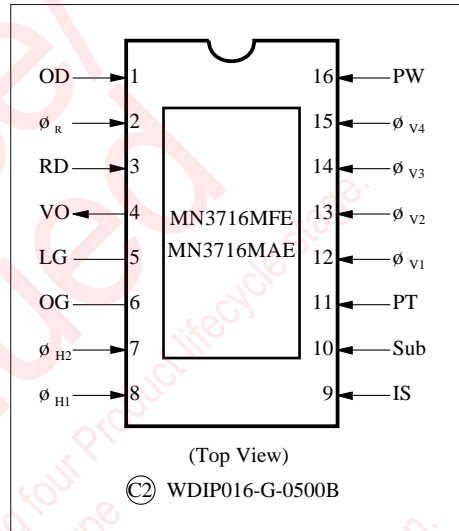
This device has a total of 270K pixels (542 horizontal × 494 vertical) and provides stable and clear images with a resolution of 330 horizontal TV-lines and 350 vertical TV-lines.

Type No.	Size	System	Color or B/W
MN3716MFE	6mm (1/3 inch)	NTSC	Color
MN3716MAE		E I A	B/W

■ Features

- Total number of pixels: 542 (horizontal) × 494 (vertical)
- High sensitivity
- Low noise
- Broad dynamic range
- Low smear
- Low image lag
- Electronic shutter function present
- No image distortion
- Small size enables design of compact equipment
- High reliability
- 16 Pin DIL ceramic package (surdip)

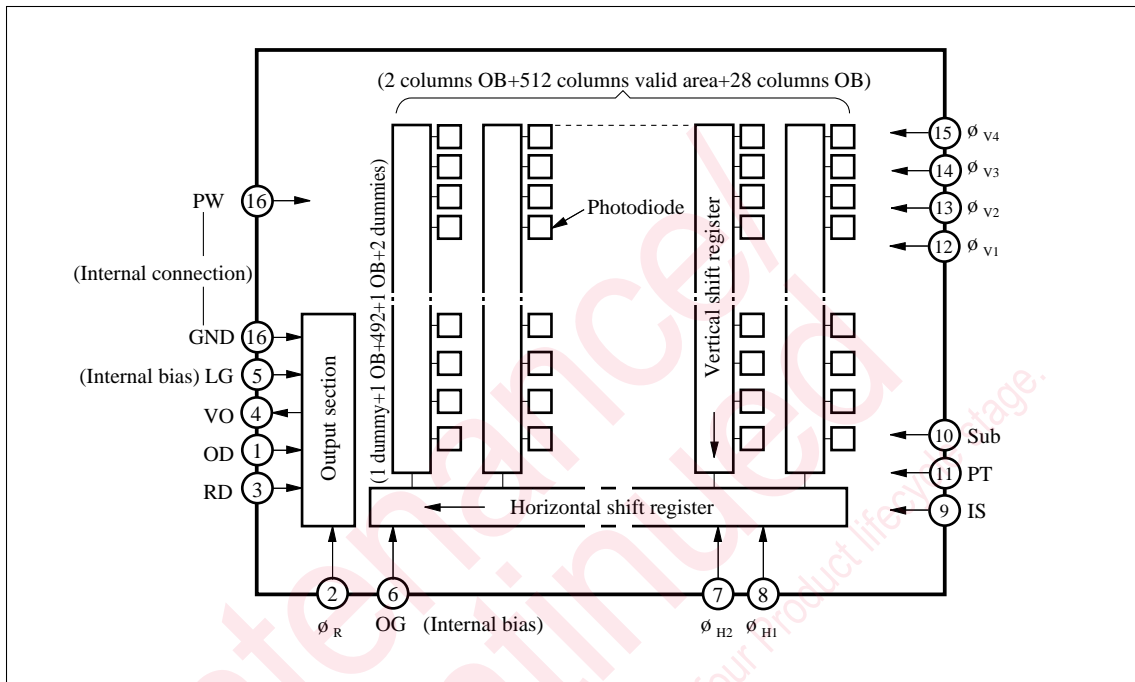
■ Pin Assignments



■ Applications

- Compact lightweight camcoders
- Communication television systems
- Door cameras
- Cameras for measurement use
- Cameras for medical use
- Picture processing

■ Block Diagram



■ Pin Descriptions

Pin No.	Symbol	Descriptions	Pin No.	Symbol	Descriptions
1	OD	Output drain	9	IS	Input source
2	ϕ_R	Reset pulse	10	Sub	Substrate
3	RD	Reset drain	11	PT	P-well for protection circuit
4	VO	Video output	12	ϕ_{V1}	Vertical shift register clock pulse (1)
5	LG	Output load transistor gate	13	ϕ_{V2}	Vertical shift register clock pulse (2)
6	OG	Output gate	14	ϕ_{V3}	Vertical shift register clock pulse (3)
7	ϕ_{H2}	Horizontal register clock pulse (2)	15	ϕ_{V4}	Vertical shift register clock pulse (4)
8	ϕ_{H1}	Horizontal register clock pulse (1)	16	PW	P-well

■ Absolute Maximum Ratings and Operating Conditions

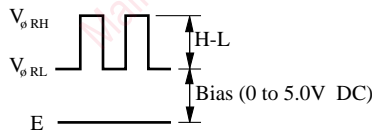
Parameter	Symbol	Rating ^{Note 2)}		Operating condition ^{Note 1)}			Unit	
		min	max	min	typ	max		
Reset drain voltage	V _{RD}	-0.2	18	14.5	15.0	15.5	V	
Output drain voltage	V _{OD}	-0.2	18	14.5	15.0	15.5	V	
Output load transistor gate voltage	V _{LG}	(Supplied internally)					V	
Output gate voltage	V _{OG}	(Supplied internally)					V	
Horizontal CCD input source voltage	V _{HS}	-0.2	18	14.5	15.0	15.5	V	
Protection P well voltage	V _{PT}	-10	0.2	ϕ _{V(L)} -1.2	ϕ _{V(L)} -1	ϕ _{V(L)} -0.7	V	
P well voltage	V _{PW}	Reference voltage		—	0	—	V	
Reset pulse voltage	H-L	V _{ϕR(H)} ^{*1}	—	18	4.7	5	5.3	V
	Bias	V _{ϕR(L)} ^{*1}	-0.2	—	0	Adjust	5.0	V
Horizontal register clock pulse voltage 1		V _{ϕH1(H)}	—	18	4.5	5	5.5	V
		V _{ϕH1(L)}	-0.2	—	-0.1	0	0.1	V
Horizontal register clock pulse voltage 2		V _{ϕH2(H)}	—	18	4.5	5	5.5	V
		V _{ϕH2(L)}	-0.2	—	-0.1	0	0.1	V
Vertical shift register clock pulse voltage 1		V _{ϕV1(H)}	—	18	14.5	15	15.5	V
		V _{ϕV1(M)}	—	—	-0.2	0	0.2	V
		V _{ϕV1(L)}	-9	—	-7.3	-7	-6.7	V
Vertical shift register clock pulse voltage 2		V _{ϕV2(M)}	—	15	0.8	1	1.2	V
		V _{ϕV2(L)}	-9	—	-7.3	-7	-6.7	V
Vertical shift register clock pulse voltage 3		V _{ϕV3(H)}	—	18	14.5	15	15.5	V
		V _{ϕV3(M)}	—	—	-0.2	0	0.2	V
		V _{ϕV3(L)}	-9	—	-7.3	-7	-6.7	V
Vertical shift register clock pulse voltage 4		V _{ϕV4(M)}	—	15	0.8	1	1.2	V
		V _{ϕV4(L)}	-9	—	-7.3	-7	-6.7	V
Substrate voltage		V _{Sub} ^{*2}	-0.2	45	3	Adjust	13.8	V
		ϕV _{Sub} ^{*2}	—	—	24.5	25.0	25.5	V
Operating temperature	T _{opr}	-10	70	—	25	—	°C	
Storage temperature	T _{stg}	-30	80	—	—	—	°C	

Note 1) The initial setting of V_{Sub} shall be 8.0V and shall be adjusted to the minimum voltage at which no blooming is caused at a light input of 100 times the standard value. The standard light input is the one when the exposure is done at a specified aperture using a light source of 2856K and 1050nt, and placing a color temperature conversion filter LB-40 (Hoya) and an IR cutting filter CAW-500S (t=2.5mm) in the light path.

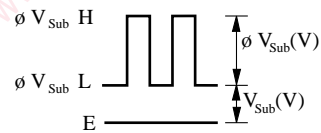
Note 2) Absolute maximum ratings: -0.2 < V_{Sub} - V_{PT} < -55 (V)
 -0.2 < V_{ϕV} - V_{PT} < +24.5 (V)

Note 3) The LG and OG pins should each be grounded via a capacitor of 0.047μF or more.

*1



*2 V_{Sub} when using electronic shutter function

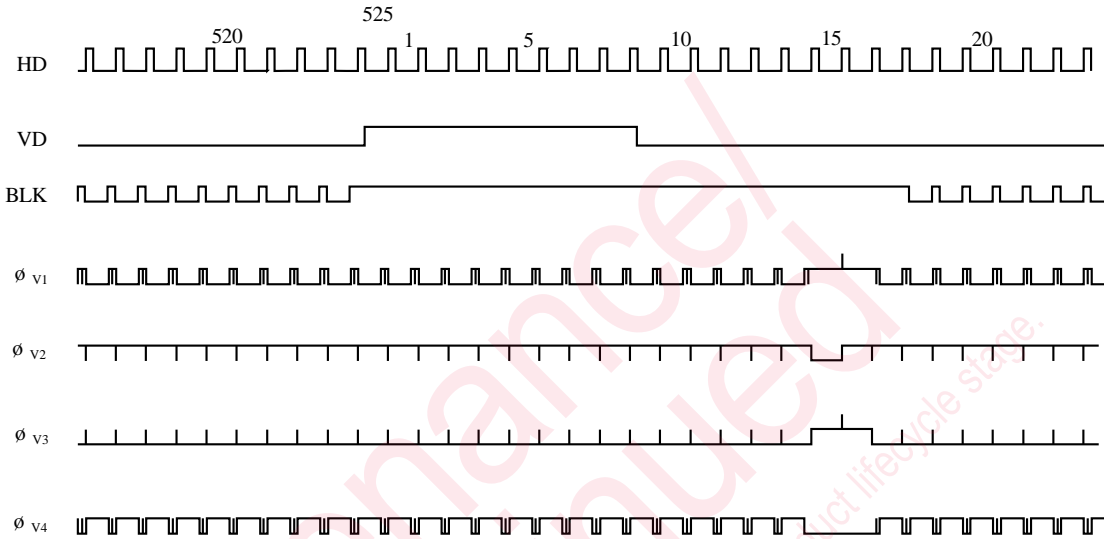


■ Optical Characteristics

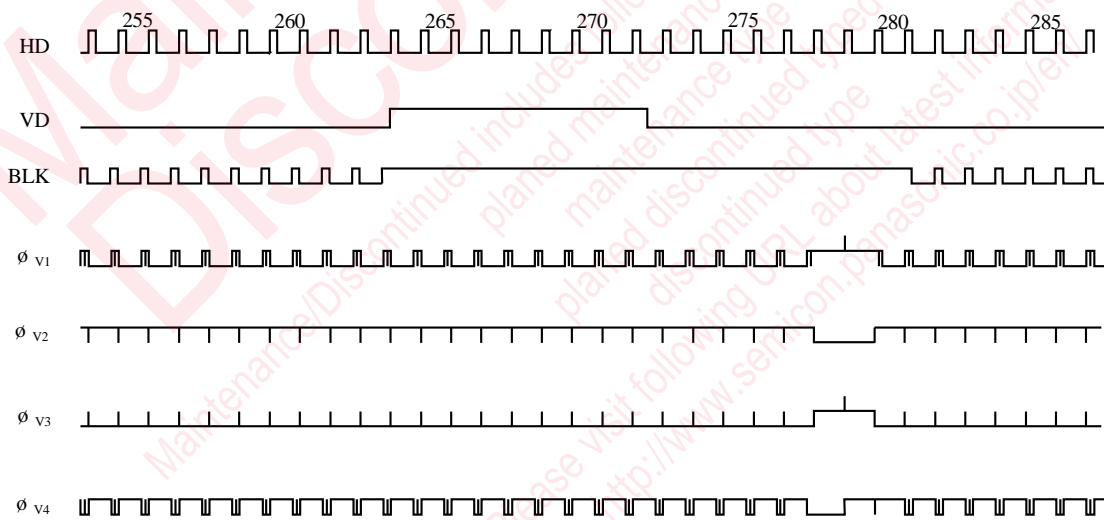
Type No.	Color or B/W	Valid pixels		S/N typ. (dB)	Saturation output typ. (mV)	Sensitivity F8 typ. (mV)	Vertical smear Sm typ. (%)	Image lag typ. (%)	Horizontal resolution typ. (TV-lines)	Vertical resolution typ. (TV-lines)
		H	V							
MN3716MFE	Color	512	492	60	900	350	0.002	0	330	350
MN3716MAE	B/W	512	492	60	1,500	500	0.003	0	360	350

■ Example of Recommended Driving Pulses

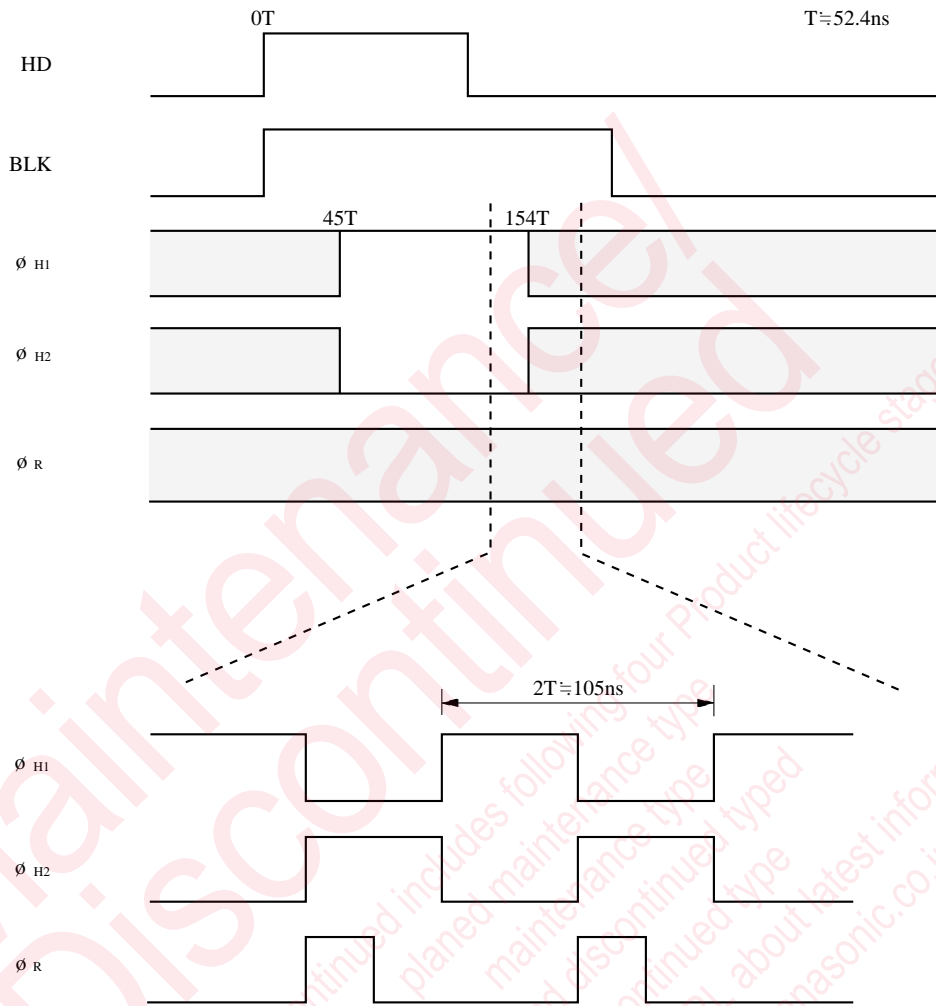
<Field A >



<Field B >



■Example of Recommended Driving Pulses (continued)



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